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## SLPS215C - JANUARY 2010-REVISED SEPTEMBER 2010

# 30V, N-Channel NexFET<sup>™</sup> Power MOSFETs

Check for Samples: CSD17301Q5A

# **FEATURES**

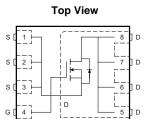
- **Optimized for 5V Gate Drive**
- Ultralow Q<sub>g</sub> and Q<sub>gd</sub>
- Low Thermal Resistance
- **Avalanche Rated**
- **Pb Free Terminal Plating**
- **RoHS Compliant**
- **Halogen Free**
- SON 5-mm × 6-mm Plastic Package

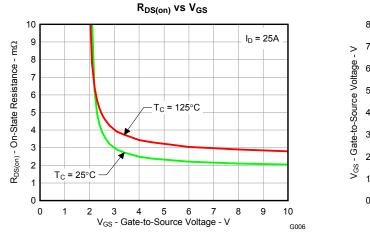
### **APPLICATIONS**

- **Notebook Point of Load**
- Point-of-Load Synchronous Buck in Networking, Telecom and Computing Systems
- **Optimized for Synchronous FET Applications**

# DESCRIPTION

The NexFET™ power MOSFET has been designed to minimize losses in power conversion applications, and optimized for 5V gate drive applications.





#### **PRODUCT SUMMARY**

V <sub>DS</sub>	Drain to Source Voltage	30	V			
Qg	Gate Charge Total (4.5V) 19					
$Q_{gd}$	Gate Charge Gate to Drain	4.3	nC			
R <sub>DS(on)</sub>		$V_{GS} = 3V$	2.9	mΩ		
	Drain to Source On Resistance	V <sub>GS</sub> = 4.5V 2.3		mΩ		
		V <sub>GS</sub> = 8V 2		mΩ		
V <sub>GS(th)</sub>	Threshold Voltage	1.1	V			

#### **ORDERING INFORMATION**

Device	Package	Media	Qty	Ship
CSD17301Q5A	SON 5-mm × 6-mm Plastic Package	13-inch reel	2500	Tape and Reel

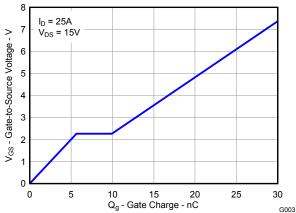
#### **ABSOLUTE MAXIMUM RATINGS**

T <sub>A</sub> = 2	T <sub>A</sub> = 25°C unless otherwise stated VALUE U								
V <sub>DS</sub>	Drain to Source Voltage	30	V						
V <sub>GS</sub>	Gate to Source Voltage	+10 /8	V						
I <sub>D</sub>	Continuous Drain Current, $T_C = 25^{\circ}C$	100	А						
	Continuous Drain Current <sup>(1)</sup>	28	А						
I <sub>DM</sub>	Pulsed Drain Current, $T_A = 25^{\circ}C^{(2)}$	181	А						
PD	Power Dissipation <sup>(1)</sup>	3.2	W						
T <sub>J</sub> , T <sub>STG</sub>	Operating Junction and Storage Temperature Range	-55 to 150	°C						
E <sub>AS</sub>	Avalanche Energy, single pulse I <sub>D</sub> = 91A, L = 0.1mH, R <sub>G</sub> = $25\Omega$	414	mJ						

(1) Typical  $R_{\theta JA} = 39^{\circ}C/W$  on 1-inch<sup>2</sup> (6.45-cm<sup>2</sup>), 2-oz. (0.071-mm thick) Cu pad on a 0.06-inch (1.52-mm) thick FR4 РСВ.

GATE CHARGE

(2) Pulse duration ≤300µs, duty cycle ≤2%



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XAS STRUMENTS

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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

# **ELECTRICAL CHARACTERISTICS**

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Static Cl	naracteristics				I	
<b>BV</b> <sub>DSS</sub>	Drain to Source Voltage	$V_{GS} = 0V, I_D = 250\mu A$	30			V
I <sub>DSS</sub>	Drain to Source Leakage Current	$V_{GS} = 0V, V_{DS} = 24V$			1	μA
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{DS} = 0V, V_{GS} = +10 / -8V$			100	nA
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	0.9	1.1	1.55	V
		$V_{GS} = 3V$ , $I_D = 25A$		2.9	3.7	mΩ
R <sub>DS(on)</sub>	Drain to Source On Resistance	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 25A		2.3	3	mΩ
		$V_{GS} = 8V, I_D = 25A$	2		2.6	mΩ
9 <sub>fs</sub>	Transconductance	V <sub>DS</sub> = 15V, I <sub>D</sub> = 25A		149		S
Dynamic	Characteristics					
C <sub>iss</sub>	Input Capacitance			2660	3480	pF
C <sub>oss</sub>	Output Capacitance	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 15V, f = 1MHz		1420	1850	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			80	105	pF
R <sub>G</sub>	Series Gate Resistance			1.3	2.6	Ω
Qg	Gate Charge Total (4.5V)			19	25	nC
Q <sub>gd</sub>	Gate Charge Gate to Drain			4.3		nC
Q <sub>gs</sub>	Gate Charge Gate to Source	$V_{DS} = 15V, I_{D} = 25A$		5.7		nC
Q <sub>g(th)</sub>	Gate Charge at Vth			2.9		nC
Q <sub>oss</sub>	Output Charge	$V_{DS} = 14V, V_{GS} = 0V$		35		nC
t <sub>d(on)</sub>	Turn On Delay Time			10.7		ns
t <sub>r</sub>	Rise Time			16.2		ns
t <sub>d(off)</sub>	Turn Off Delay Time	$V_{DS} = 15V, V_{GS} = 4.5V, I_D = 25A, R_G = 2\Omega$		28		ns
t <sub>f</sub>	Fall Time			10.5		ns
Diode Cl	haracteristics				1	
V <sub>SD</sub>	Diode Forward Voltage	I <sub>SD</sub> = 25A, V <sub>GS</sub> = 0V		0.8	1	V
Q <sub>rr</sub>	Reverse Recovery Charge	V 14V 1 25A di/dt 200A/c		50		nC
t <sub>rr</sub>	Reverse Recovery Time	$V_{DD}$ = 14V, I <sub>F</sub> = 25A, di/dt = 300A/µs		33		ns

## THERMAL CHARACTERISTICS

(T,	$(T_A = 25^{\circ}C \text{ unless otherwise stated})$										
	PARAMETER	MIN	TYP	MAX	UNIT						
R	HJC Thermal Resistance Junction to Case <sup>(1)</sup>			2.2	°C/W						
R	<sub>DJA</sub> Thermal Resistance Junction to Ambient <sup>(1)(2)</sup>			49	°C/W						

 $R_{\theta JC}$  is determined with the device mounted on a 1-inch<sup>2</sup> (6.45-cm<sup>2</sup>), 2-oz. (0.071-mm thick) Cu pad on a 1.5-inch × 1.5-inch (3.81-cm × 3.81-cm), 0.06-inch (1.52-mm) thick FR4 PCB.  $R_{\theta JC}$  is specified by design, whereas  $R_{\theta JA}$  is determined by the user's board design. Device mounted on FR4 material with 1-inch<sup>2</sup> (6.45-cm<sup>2</sup>), 2-oz. (0.071-mm thick) Cu. (1)

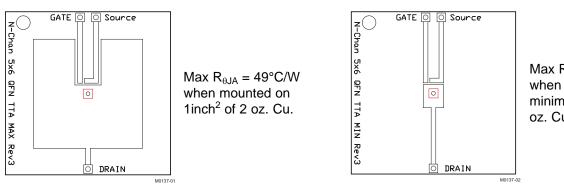
(2)



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# CSD17301Q5A

#### SLPS215C - JANUARY 2010-REVISED SEPTEMBER 2010



Max  $R_{\theta JA} = 120^{\circ}C/W$ when mounted on minimum pad area of 2 oz. Cu.

## **TYPICAL MOSFET CHARACTERISTICS**

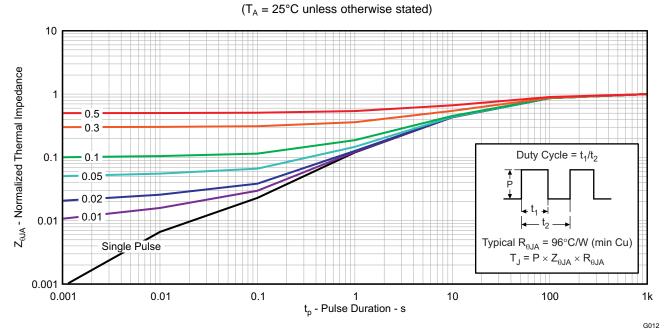


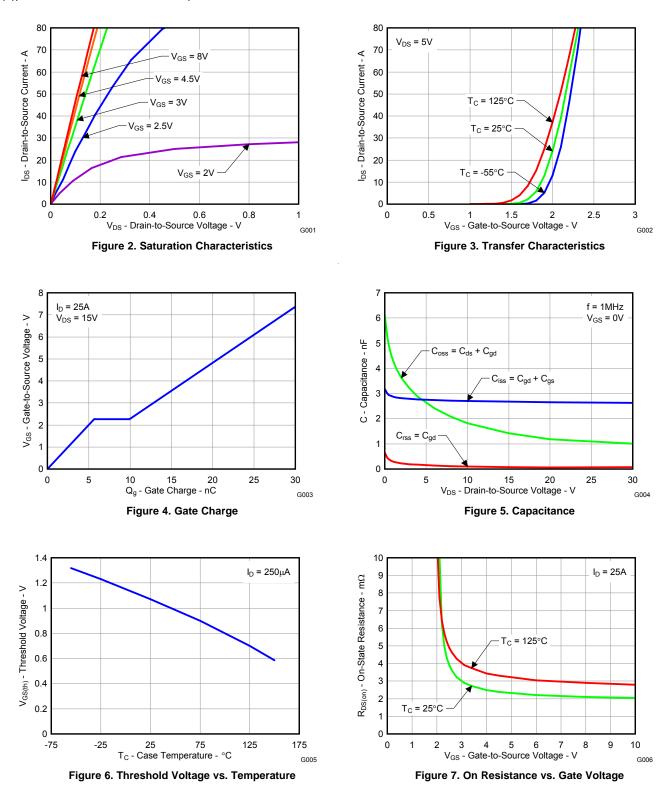
Figure 1. Transient Thermal Impedance

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## **TYPICAL MOSFET CHARACTERISTICS (continued)**

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 



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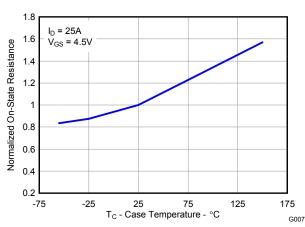


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#### **TYPICAL MOSFET CHARACTERISTICS (continued)**

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 





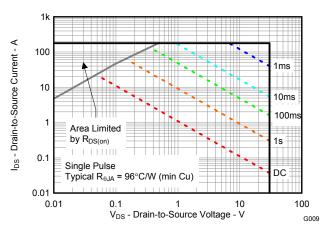


Figure 10. Maximum Safe Operating Area

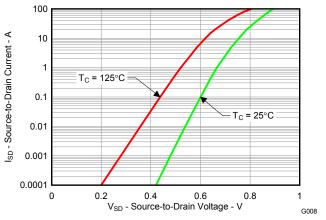


Figure 9. Typical Diode Forward Voltage

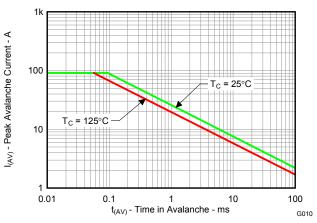
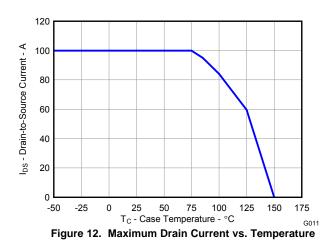


Figure 11. Single Pulse Unclamped Inductive Switching



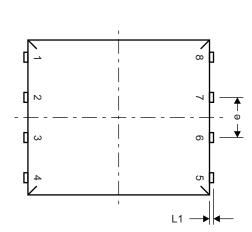
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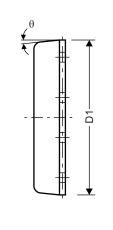
TEXAS INSTRUMENTS

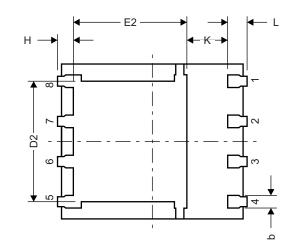
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## **MECHANICAL DATA**

# **Q5A Package Dimensions**



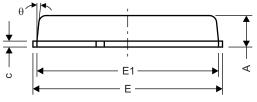




Top View

Side View

**Bottom View** 



Front View

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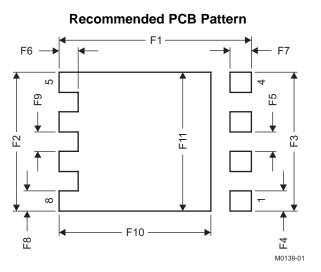
DIM		MILLIMETERS	
DIM	MIN	NOM	MAX
A	0.90	1.00	1.10
b	0.33	0.41	0.51
С	0.20	0.25	0.34
D1	4.80	4.90	5.00
D2	3.61	3.81	4.02
E	5.90	6.00	6.10
E1	5.70	5.75	5.80
E2	3.38	3.58	3.78
е	1.17	1.27	1.37
Н	0.41	0.56	0.71
К	1.10		
L	0.51	0.61	0.71
L1	0.06	0.13	0.20
θ	0°		12°



# CSD17301Q5A

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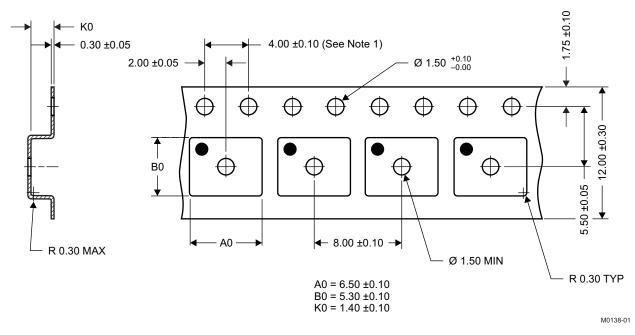
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DIM	MILLIM	IETERS	INCHES			
DIN	MIN	МАХ	MIN	MAX		
F1	6.205	6.305	0.244	0.248		
F2	4.46	4.56	0.176	0.18		
F3	4.46	4.56	0.176	0.18		
F4	0.65	0.7	0.026	0.028		
F5	0.62	0.67	0.024	0.026		
F6	0.63	0.68	0.025	0.027		
F7	0.7	0.8	0.028	0.031		
F8	0.65	0.7	0.026	0.028		
F9	0.62	0.67	0.024	0.026		
F10	4.9	5	0.193	0.197		
F11	4.46	4.56	0.176	0.18		

For recommended circuit layout for PCB designs, see application note SLPA005 – Reducing Ringing Through PCB Layout Techniques.

#### **Q5A Tape and Reel Information**



#### Notes:

- 1. 10-sprocket hole-pitch cumulative tolerance ±0.2
- 2. Camber not to exceed 1mm in 100mm, noncumulative over 250mm
- 3. Material: black static-dissipative polystyrene
- 4. All dimensions are in mm (unless otherwise specified)
- 5. A0 and B0 measured on a plane 0.3mm above the bottom of the pocket

SLPS215C - JANUARY 2010-REVISED SEPTEMBER 2010

8

# **REVISION HISTORY**

#### Changes from Original (January) to Revision A Page Changed the Abs Max Ratings table, Avalanche Energy, single pulse From: $I_D$ = 85A, L = 0.1mH, $R_G$ = 25 $\Omega$ Value = Changed Figure 11 ...... 5

### Changes from Revision A (February 2010) to Revision B

•	Updated the Q5A Package Dimensions table. DIM c MAX was 0.30, DIM D2 MAX was 3.96, DIM e MIN was blank MAX was blank, DIM H NOM was 0.51 MAX was 0.61	6
•	Deleted Note 6 from the Q5A Tape and Reel Information - "MSL1 260°C (IR and convection) PbF reflow compatible"	
•	Deleted the Package Marking Information section	7
Cł	nanges from Revision B (July 2010) to Revision C	age

•	Changed the Abs Max Ratings table, Pulsed Drain Current value From: 118 To: 181 1
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#### Page



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# PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
CSD17301Q5A	ACTIVE	VSONP	DQJ	8	2500	RoHS-Exempt & Green	SN	Level-1-260C-UNLIM	-55 to 150	CSD17301	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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